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FQP3N80C / FQPF3N80C N-Channel QFET[®] MOSFET 800 V, 3.0 A, 4.8 Ω

Features

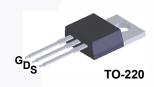
- 3.0 A, 800 V, ${\rm R}_{\rm DS(on)}$ = 4.8 Ω (Max.) @ V_{\rm GS} = 10 V, ${\rm I}_{\rm D}$ = 1.5 A
- Low Gate Charge (Typ. 13 nC)
- Low Crss (Typ. 5.5 pF)
- 100% Avalanche Tested

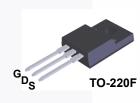
June 2014

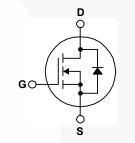
FQP3N80C / FQPF3N80C — N-Channel QFET[®] MOSFET

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.







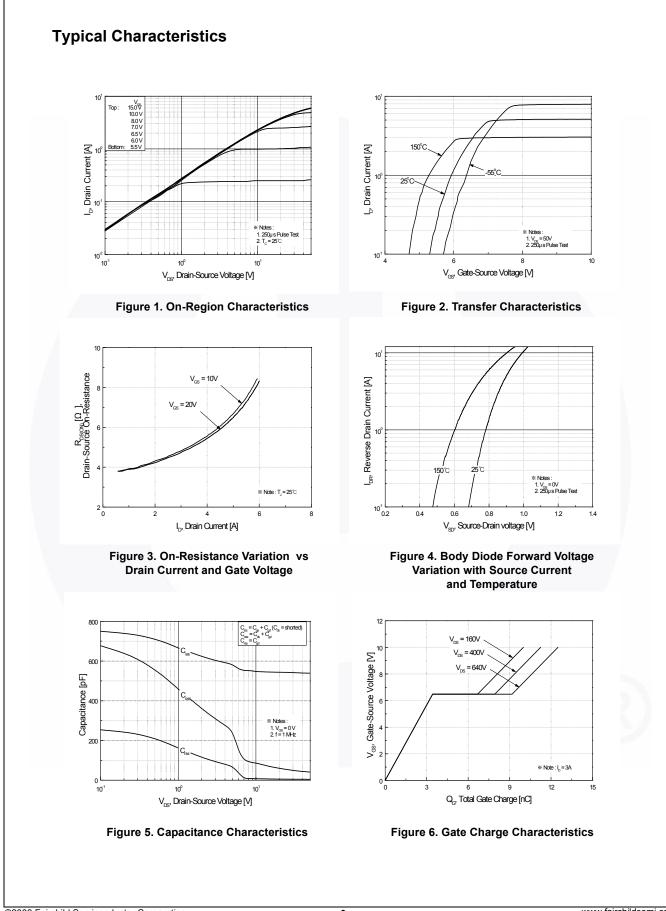
MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

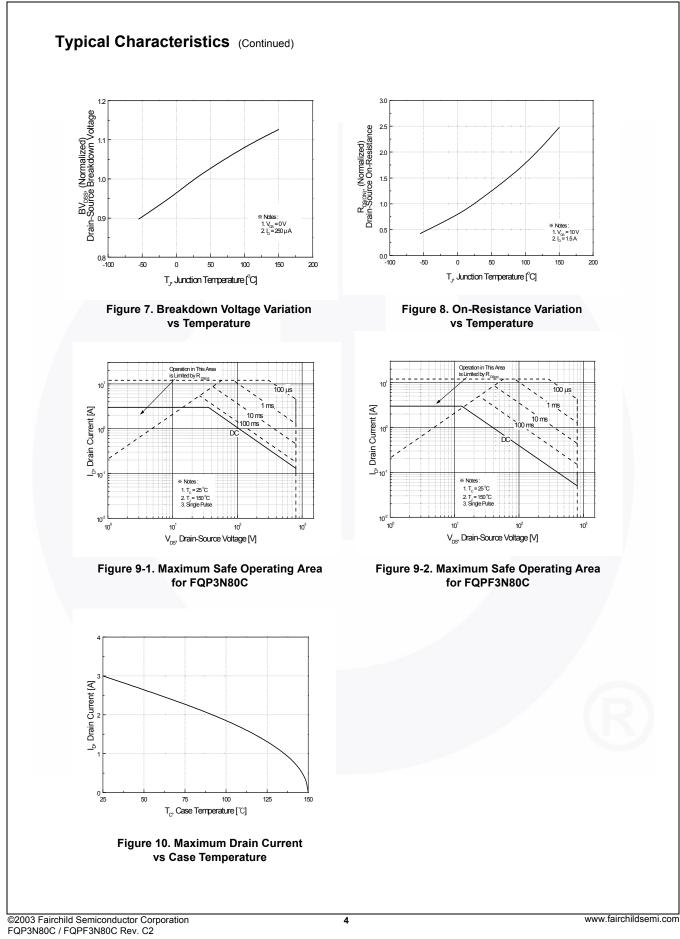
Symbol		Parameter	FQP3N80C	FQPF3N80C	Unit	
V _{DSS}	Drain to Source Voltage	9		8	V	
I _D	Ducin Current	-Continuous (T _C = 25 ^o C)	-Continuous (T _C = 25 ^o C) -Continuous (T _C = 100 ^o C)			А
	Drain Current	-Continuous (T _C = 100 ^o C)				Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	12	12 *	Α
V _{GSS}	Gate to Source Voltage			±	V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	3	mJ	
I _{AR}	Avalanche Current				А	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	1(mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5		V/ns
P _D	Dower Dissinction	(T _C = 25°C)	(T _C = 25°C)		39	W
	Power Dissipation	- Derate above 25°C	- Derate above 25ºC		0.31	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			3	°C	
*Drain current l	limited by maximum junction					

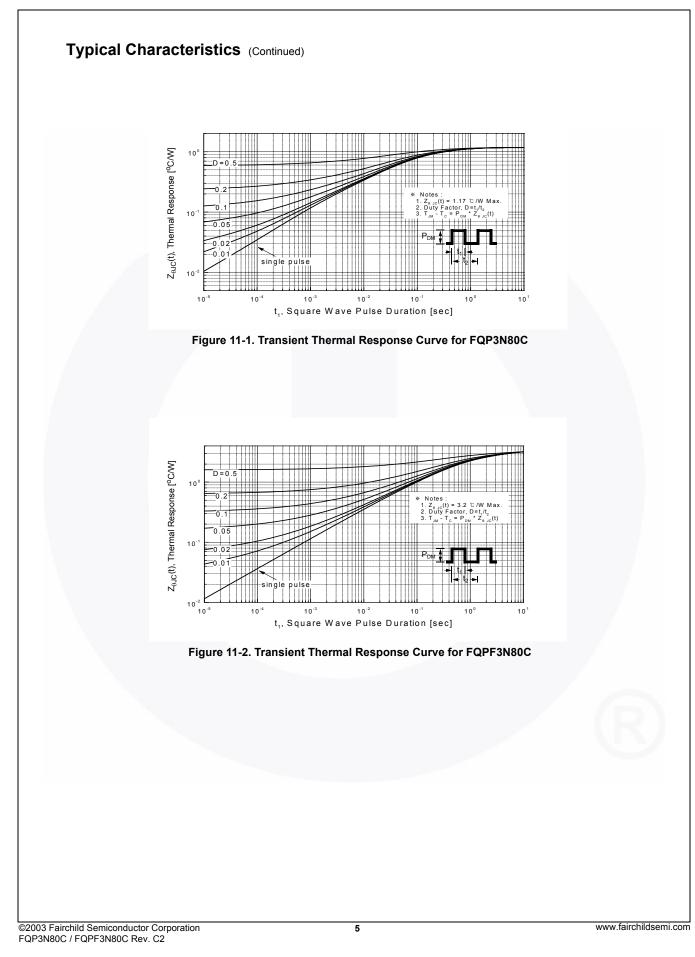
Thermal Characteristics

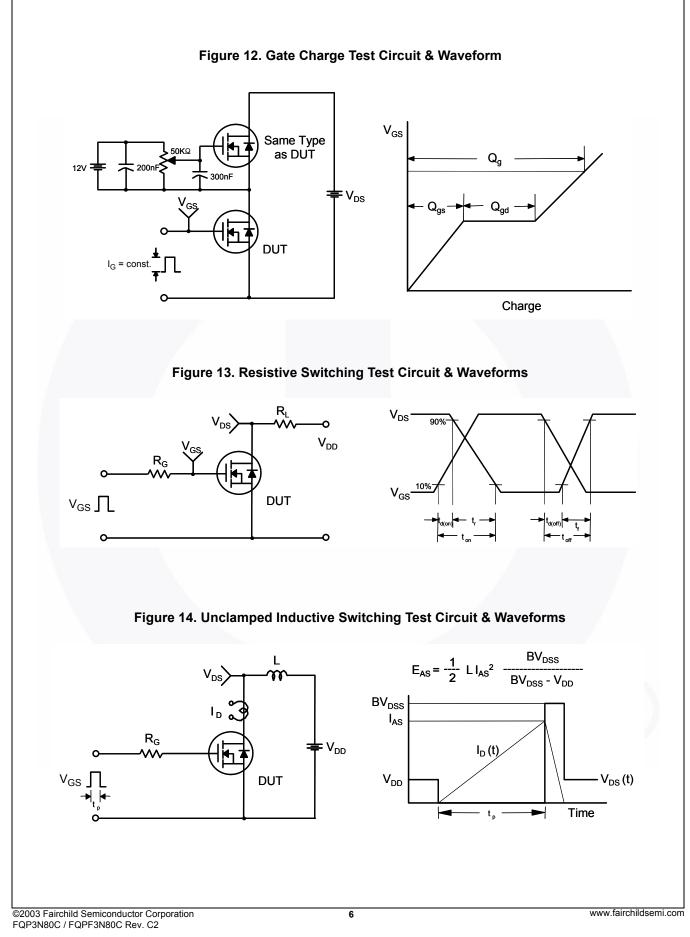
Symbol	Parameter	FQP3N80C	FQPF3N80C	Unit	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max	1.17	3.2	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max	62.5	62.5	°C/W	

FQP:		Top Mark	Fac	kage	Packing Method	Reel	Size	Tape Widtl	n Qu	antity	
		FQP3N80C	TO	220	Tube	Tu	ıbe	N/A	50	50 units	
		TO-2	220F Tube Tu		ibe	N/A	50	50 units			
lectric	al Char	acteristics $T_c =$	25ºC ur	less oth	erwise noted.						
Symbol		Parameter			Test Conditions		Min	Тур	Мах	Unit	
Off Cha	racteristi	cs									
BV _{DSS}	Drain-Source Breakdown Voltage		V _{GS} = 0 V, I _D = 250 μA			800			V		
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient		$I_D = 250 \ \mu$ A, Referenced to 25°C				1		V/°C		
J	Zero Gate Voltage Drain Current		V _{DS} = 800 V, V _{GS} = 0 V					10	μA		
DSS				$V_{\rm DS} = 640 \text{ V}, \text{ T}_{\rm C} = 125^{\circ}\text{C}$					100	μA	
I _{GSSF}	Gate-Body Leakage Current, Forward		ward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$					100	nA	
GSSR	Gate-Body Leakage Current, Reverse			$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$					-100	nA	
				00							
V _{GS(th)}	racteristics Gate Threshold Voltage		V _{DS} = V _{GS} , I _D = 250 μA			3.0		5.0	V		
R _{DS(on)}	Static Drain-Source On-Resistance			$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$				4.0	4.8	Ω	
9 _{FS}	Forward Transconductance			V _{DS} = 50 V, I _D = 1.5 A				3		S	
C _{iss} C _{oss} C _{rss}	c Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance		V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz				543 54 5.5	705 70 7.5	pF pF pF		
Switchi	ng Chara	cteristics									
d(on)	ng Characteristics Turn-On Delay Time							15	40	ns	
r	Turn-On Rise Time		_	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 3 \text{ A},$ R _G = 25 Ω				43.5	95	ns	
d(off)		rn-Off Delay Time						22.5	55	ns	
f	Turn-Off Fa	,		-		(Note 4)		32	75	ns	
Qg	Total Gate			\/	640 V I_ = 3 A			13	16.5	nC	
Q _{gs}	Gate-Sourc			V _{DS} = 640 V, I _D = 3 A, V _{GS} = 10 V				3.4		nC	
Q _{gd}	Gate-Drain	•		• 68 -		(Note 4)		5.8		nC	
brain-S		de Characteristi Continuous Drain-Sour			<u> </u>				3.0	A	
SM	Maximum Pulsed Drain-Source Diode For								12	A	
V _{SD}		ce Diode Forward Volta			0 V, I _S = 3.0 A				1.4	V	
t _{rr}		ecovery Time			0 V, I _S = 3.0 A,			642		ns	
Q _{rr}		ecovery Charge		$dl_{\rm F} / dt = 100 {\rm A}/{\mu {\rm s}}$				4.0		μC	
111		in the second seco								μΟ	









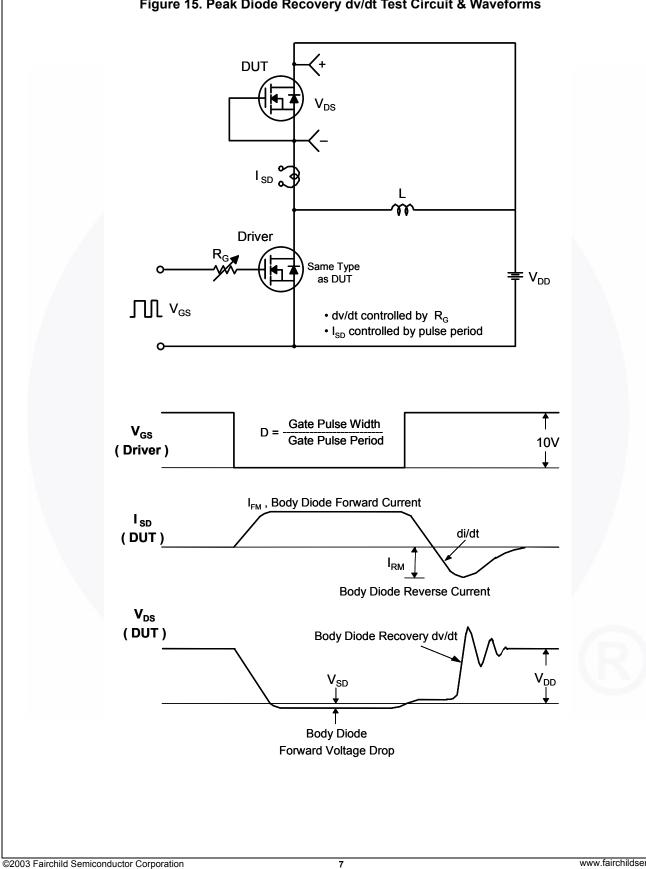
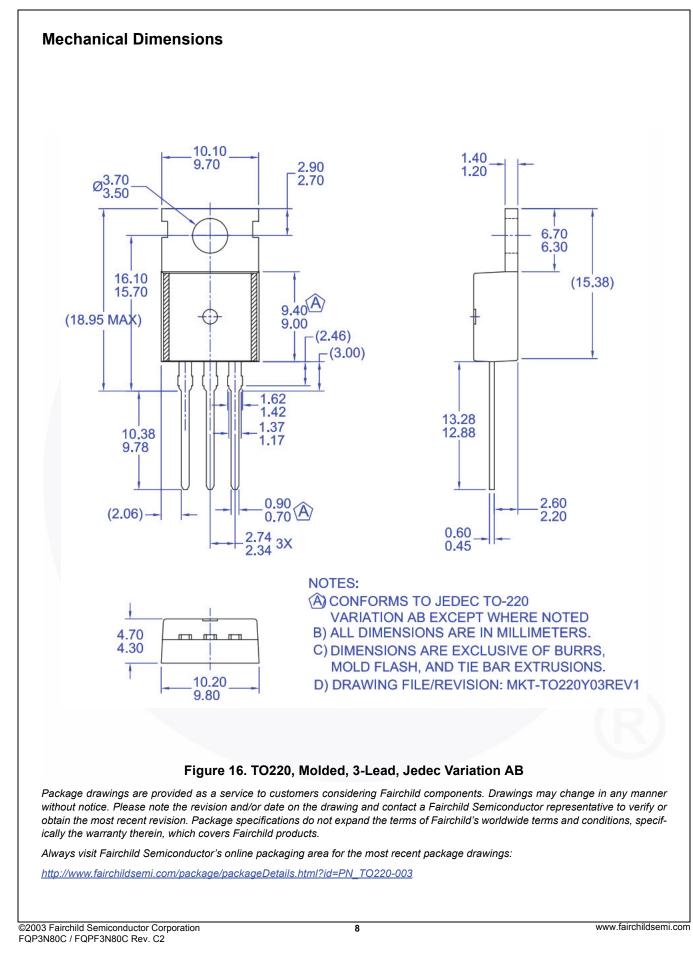
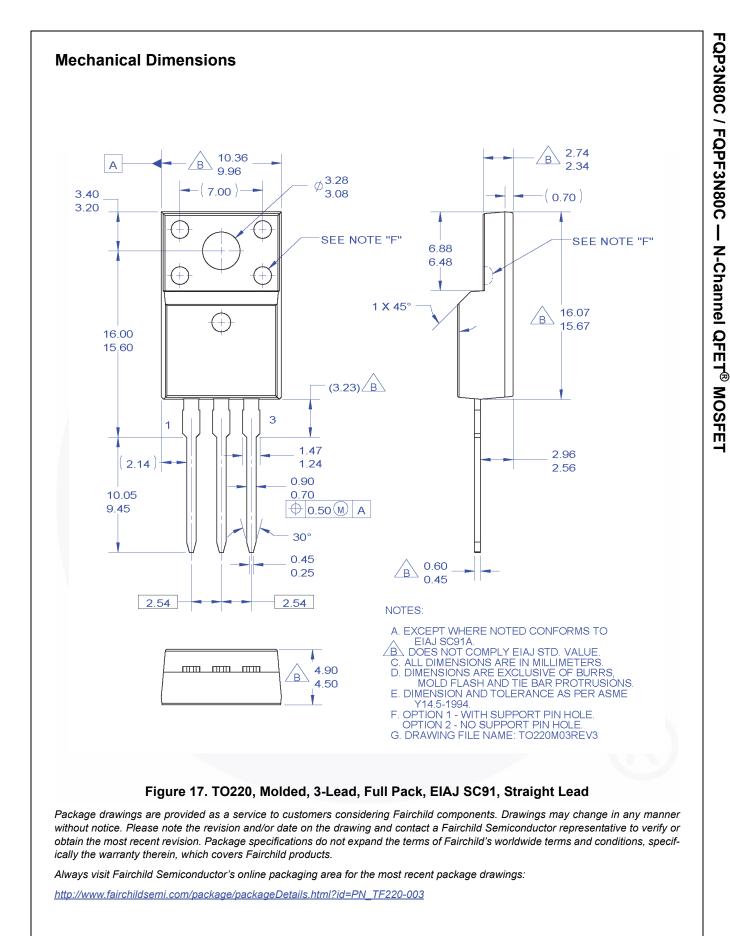


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms







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